FCC Test Report

Applicant	:	**Eanovo Technology (Shenzhen) Co.,Ltd**
Address	:	**A Building, ShangXue Technology Industrial Park, Bantian, LongGang, Shenzhen, Guangdong, 518000, China**
Product Name	:	**11.6 inch Yoga Laptop**
Report Date	:	**Nov. 10, 2023**

Shenzhen Anbotek Compliance Laboratory Limited

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TEST REPORT

Applicant	:	Eanovo Technology (Shenzhen) Co.,Ltd
Manufacturer	:	Eanovo Technology (Shenzhen) Co.,Ltd
Product Name	:	11.6 inch Yoga Laptop
Test Model No.	:	EA-Y116
Reference Model No.	:	EA-N116, EA-N116S, EA-N133, EA-Y133, EA-N133S, EA-N14, EA-N14S, EA-N14H, EA-N15, EA-N15S, EA-N15H
Trade Mark	:	EANOVO
Rating(s)	:	Input: 12V⎓ 2A (with DC 7.6V, 5000mAh battery inside)
Test Standard(s)	:	**FCC Part15 Subpart C, Section 15.247**
Test Method(s)	:	**ANSI C63.10: 2020**

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 15 Subpart C requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of receipt	Oct. 25, 2023
Date of Test	Oct. 25 ~ Nov. 07, 2023
Prepared by	Nianxiu Chen (Nianxiu Chen)
Approved & Authorized Signer	Edward pan (Edward Pan)

Revision History

Report Version	Description	Issued Date
R00	Original Issue.	Nov. 10, 2023

Address:1/F.,Building D,Sogood Science and Technology Park, Sanwei Community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.
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1. General Information

1.1. Client Information

Applicant	:	Eanovo Technology (Shenzhen) Co.,Ltd
Address	:	A Building, ShangXue Technology Industrial Park, Bantian, LongGang, Shenzhen, Guangdong, 518000, China
Manufacturer	:	Eanovo Technology (Shenzhen) Co.,Ltd
Address	:	A Building, ShangXue Technology Industrial Park, Bantian, LongGang, Shenzhen, Guangdong, 518000, China
Factory	:	Eanovo Technology (Shenzhen) Co.,Ltd
Address	:	A Building, ShangXue Technology Industrial Park, Bantian, LongGang, Shenzhen, Guangdong, 518000, China

1.2. Description of Device (EUT)

Product Name	:	11.6 inch Yoga Laptop
Test Model No.	:	EA-Y116
Reference Model No.	:	EA-N116, EA-N116S, EA-N133, EA-Y133, EA-N133S, EA-N14, EA-N14S, EA-N14H, EA-N15, EA-N15S, EA-N15H (Note: All samples are the same except the model number and appearance color, so we prepare "EA-Y116" for test only.)
Trade Mark	:	EANOVO
Test Power Supply	:	AC 120V, 60Hz for Adapter/ DC 7.6V Battery inside
Test Sample No.	:	1-2-1(Normal Sample), 1-2-2(Engineering Sample)
Adapter	:	Model: BCT120200-161UX Input: 100-240V~50/60Hz Max. 0.8A Output: 12V⎓ 2000mA
RF Specification		
Operation Mode	:	☒ BT BDR ☒ BT EDR
Operation Frequency	:	2402~2480MHz
Number of Channel	:	79 Channels
Modulation Type	:	GFSK, π/4-DQPSK, 8-DPSK
Antenna Type	:	FPC Antenna
Antenna Gain(Peak)	:	3.16 dBi
Remark: 1) All of the RF specification are provided by customer. 2) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.		

1.3. Auxiliary Equipment Used During Test

Description	Rating(s)
--	--

1.4. Description of Test Configuration

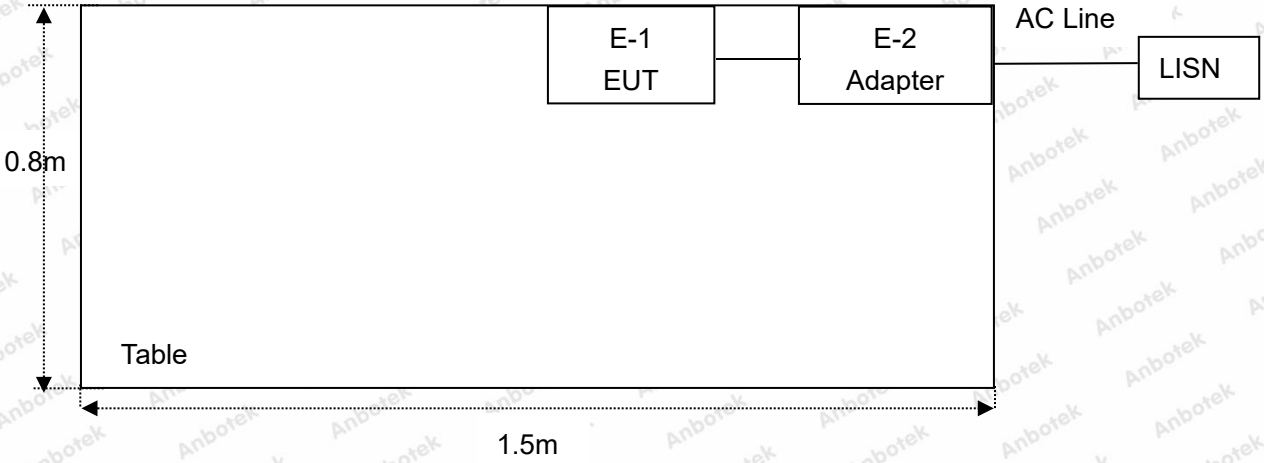
Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)
00	**2402**	17	2419	34	2436	51	2453	68	2470
01	2403	18	2420	35	2437	52	2454	69	2471
02	2404	19	2421	36	2438	53	2455	70	2472
03	2405	20	2422	37	2439	54	2456	71	2473
04	2406	21	2423	38	2440	55	2457	72	2474
05	2407	22	2424	**39**	**2441**	56	2458	73	2475
06	2408	23	2425	40	2442	57	2459	74	2476
07	2409	24	2426	41	2443	58	2460	75	2477
08	2410	25	2427	42	2444	59	2461	76	2478
09	2411	26	2428	43	2445	60	2462	77	2479
10	2412	27	2429	44	2446	61	2463	**78**	**2480**
11	2413	28	2430	45	2447	62	2464		
12	2414	29	2431	46	2448	63	2465		
13	2415	30	2432	47	2449	64	2466		
14	2416	31	2433	48	2450	65	2467		
15	2417	32	2434	49	2451	66	2468		
16	2418	33	2435	50	2452	67	2469		

Note:

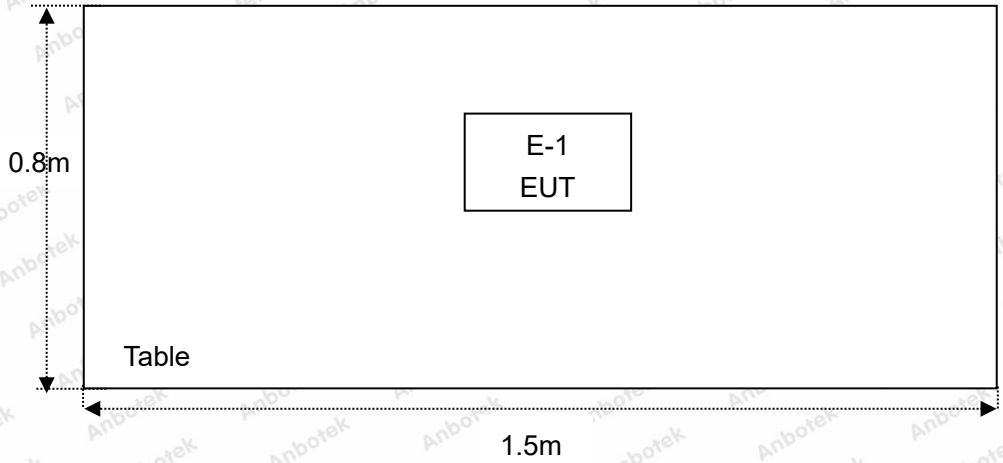
1. The engineering test program was provided and the EUT was programmed to be in continuously transmitting mode.
2. EUT was tested with channel 0, 39 and 78.

1.5. Description Of Test Setup

CE



RE



1.6. Test Equipment List

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	Oct. 12, 2023	1 Year
2.	Three Phase V-type Artificial Power Network	CYBERTEK	EM5040DT	E215040DT001	Jul. 05, 2023	1 Year
3.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Oct. 12, 2023	1 Year
4.	EMI Test Receiver	Rohde & Schwarz	ESR26	101481	Oct. 12, 2023	1 Year
5.	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Oct. 12, 2023	1 Year
6.	EMI Preamplifier	SKET Electronic	LNPA-0118G-45	SKET-PA-002	Oct. 12, 2023	1 Year
7.	Double Ridged Horn Antenna	SCHWARZBECK	BBHA 9120D	02555	Oct. 16, 2022	3 Year
8.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	345	Oct. 23, 2022	3 Year
9.	Loop Antenna	Schwarzbeck	FMZB1519B	00053	Oct. 12, 2023	1 Year
10.	Horn Antenna	A-INFO	LB-180400-KF	J211060628	Oct. 12, 2023	1 Year
11.	Pre-amplifier	SONOMA	310N	186860	Oct. 12, 2023	1 Year
12.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A
13.	MXA Spectrum Analysis	KEYSIGHT	N9020A	MY53280032	Oct. 12, 2023	1 Year
14.	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Oct. 12, 2023	1 Year
15.	Signal Generator	Agilent	E4421B	MY41000743	Oct. 12, 2023	1 Year
16.	DC Power Supply	IVYTECH	IV3605	1804D360510	Oct. 20, 2023	1 Year
17.	Constant Temperature Humidity Chamber	ZHONGJIAN	ZJ-KHWS80B	N/A	Oct. 16, 2023	1 Year
18.	Power Meter	Agilent	N1914A	MY50001102	Oct. 20, 2023	1 Year

1.7. Measurement Uncertainty

Parameter	Uncertainty
Conducted emissions (AMN 150kHz~30MHz)	3.8dB
Occupied Bandwidth	925Hz
Conducted Output Power	0.76dB
Conducted Spurious Emission	1.24dB
Radiated spurious emissions (Below 30MHz)	3.53dB
Radiated spurious emissions (30MHz~1GHz)	Horizontal: 3.92dB; Vertical: 4.52dB
Radiated spurious emissions (above 1GHz)	1G-6GHz: 4.78dB; 6G-18GHz: 4.88dB 18G-40GHz: 5.68dB
The measurement uncertainty and decision risk evaluated according to AB/WI-RF-F-032. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.	

1.8. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111.

ISED-Registration No.: 8058A

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.
1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.

1.9. Disclaimer

1. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
2. The test report is invalid if there is any evidence and/or falsification.
3. The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
4. This document may not be altered or revised in any way unless done so by Anbotek and all revisions are duly noted in the revisions section.
5. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
6. The authenticity of the information provided by the customer is the responsibility of the customer and the laboratory is not responsible for its authenticity.

The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

2. Summary of Test Results

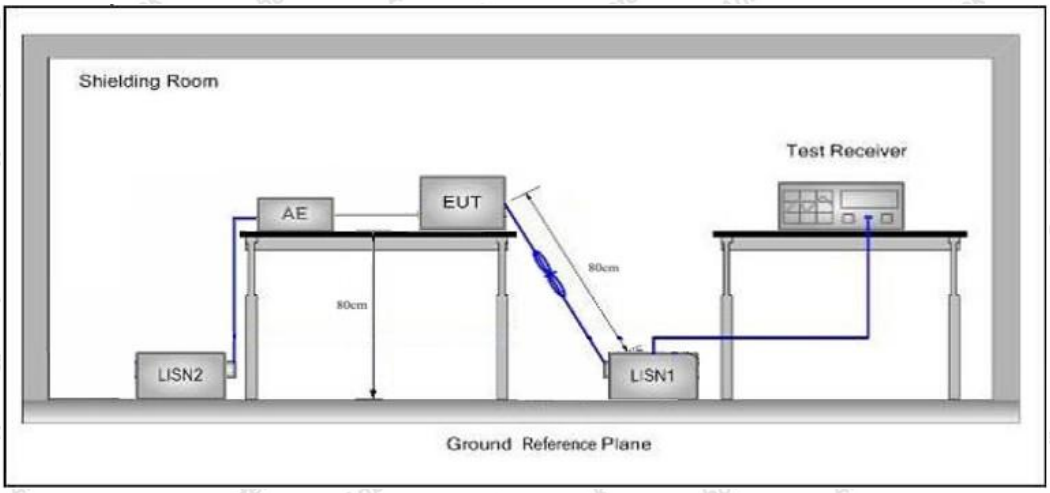
Standard Section	Test Item	Result
15.203/15.247(c)	Antenna Requirement	PASS
15.207	Conducted Emission	PASS
15.205/15.209	Spurious Emission	PASS
15.247(b)(1)	Conducted Peak Output Power	PASS
15.247(a)(1)	20dB Occupied Bandwidth	PASS
15.247(a)(1)	Carrier Frequencies Separation	PASS
15.247(a)(1)(iii)	Number of Hopping Channel	PASS
15.247(a)(1)(iii)	Dwell Time	PASS
15.247(d)	Band Edge	PASS
Remark: “N/A” is an abbreviation for Not Applicable.		

3. Conducted Emission Test

3.1. Test Standard and Limit

Test Standard	FCC Part15 Section 15.207		
Test Limit	Frequency	Maximum RF Line Voltage (dBuV)	
		Quasi-peak Level	Average Level
	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *
	500kHz~5MHz	56	46
	5MHz~30MHz	60	50
Remark: (1) *Decreasing linearly with logarithm of the frequency. (2) The lower limit shall apply at the transition frequency.			

3.2. Test Setup



3.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.10: 2020 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

3.4. Test Data

PASS

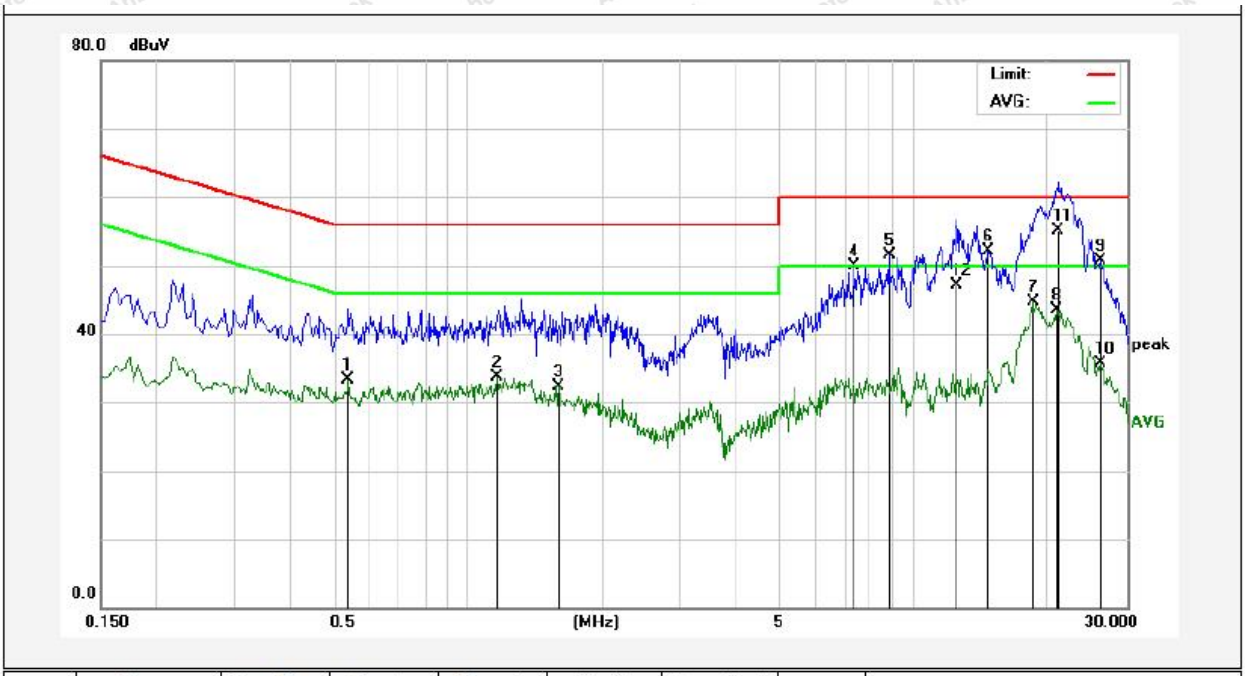
During the test, pre-scan all modes, only the worst case is recorded in the report.

AC conducted emission pre-test at both at AC 120V/60Hz and AC 240V/60Hz modes, recorded worst case AC 120V/60Hz.

Please to see the following pages.

Conducted Emission Test Data

Test Site: 1# Shielded Room
Operating Condition: GFSK (2402MHz)
Test Specification: AC 120V, 60Hz for Adapter
Comment: Live Line
Temp.(℃)/Hum.(%RH): 22.7℃/60%RH

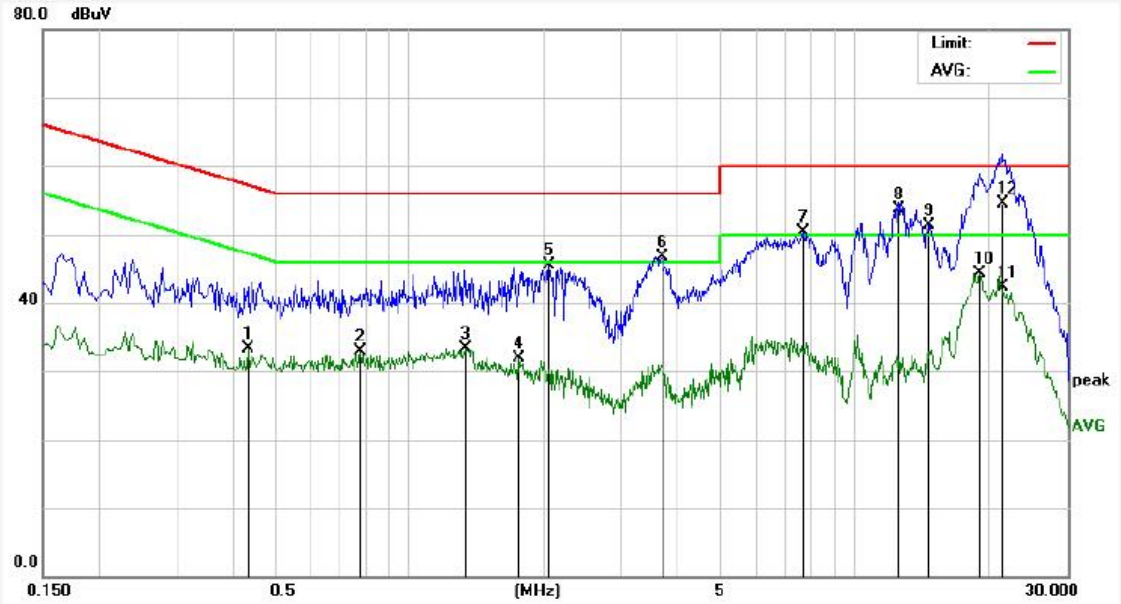


No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Over Limit (dB)	Detector	Remark
1	0.5380	13.38	19.85	33.23	46.00	-12.77	AVG	
2	1.1620	13.90	19.85	33.75	46.00	-12.25	AVG	
3	1.5940	12.51	19.84	32.35	46.00	-13.65	AVG	
4	7.3340	30.02	19.87	49.89	60.00	-10.11	QP	
5	8.7820	31.47	19.94	51.41	60.00	-8.59	QP	
6	14.7300	31.86	20.17	52.03	60.00	-7.97	QP	
7	18.5020	24.40	20.26	44.66	50.00	-5.34	AVG	
8	20.8460	23.01	20.44	43.45	50.00	-6.55	AVG	
9	26.2020	29.63	21.07	50.70	60.00	-9.30	QP	
10	26.2020	14.55	21.07	35.62	50.00	-14.38	AVG	
11	21.0580	34.61	20.47	55.08	60.00	-4.92	QP	
12	12.5020	26.98	20.07	47.05	60.00	-12.95	QP	

Note: Result = Reading + Factor Over Limit = Result - Limit

Conducted Emission Test Data

Test Site:	1# Shielded Room
Operating Condition:	GFSK (2402MHz)
Test Specification:	AC 120V, 60Hz for Adapter
Comment:	Neutral Line
Temp.(℃)/Hum.(%RH):	22.7℃/60%RH



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Over Limit (dB)	Detector	Remark
1	0.4340	13.43	19.82	33.25	47.18	-13.93	AVG	
2	0.7780	13.05	19.86	32.91	46.00	-13.09	AVG	
3	1.3340	13.49	19.84	33.33	46.00	-12.67	AVG	
4	1.7540	12.16	19.84	32.00	46.00	-14.00	AVG	
5	2.0620	25.64	19.83	45.47	56.00	-10.53	QP	
6	3.6860	26.91	19.85	46.76	56.00	-9.24	QP	
7	7.6580	30.32	19.89	50.21	60.00	-9.79	QP	
8	12.5380	33.68	20.09	53.77	60.00	-6.23	QP	
9	14.6300	31.12	20.17	51.29	60.00	-8.71	QP	
10	19.0620	24.01	20.27	44.28	50.00	-5.72	AVG	
11	21.3340	21.79	20.52	42.31	50.00	-7.69	AVG	
12	21.4660	34.06	20.54	54.60	60.00	-5.40	QP	

Note: Result = Reading + Factor Over Limit = Result - Limit

4. Radiation Spurious Emission and Band Edge

4.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.209 and 15.205				
Test Limit	Frequency (MHz)	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)
	0.009MHz~0.490MHz	2400/F(kHz)	-	-	300
	0.490MHz-1.705MHz	24000/F(kHz)	-	-	30
	1.705MHz-30MHz	30	-	-	30
	30MHz~88MHz	100	40.0	Quasi-peak	3
	88MHz~216MHz	150	43.5	Quasi-peak	3
	216MHz~960MHz	200	46.0	Quasi-peak	3
	960MHz~1000MHz	500	54.0	Quasi-peak	3
	Above 1000MHz	500	54.0	Average	3
		-	74.0	Peak	3

Remark:
(1)The lower limit shall apply at the transition frequency.
(2) 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

4.2. Test Setup

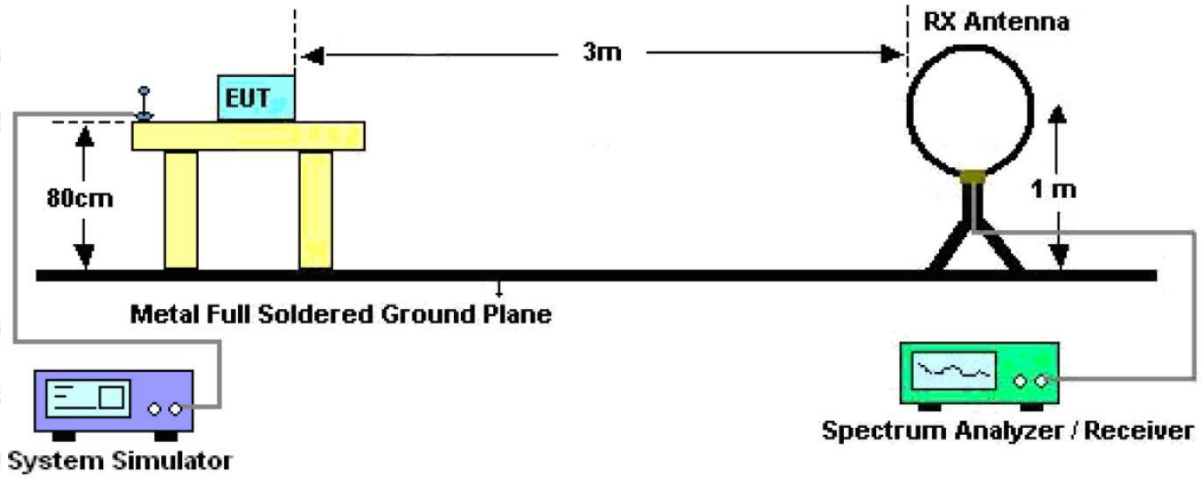


Figure 1. Below 30MHz

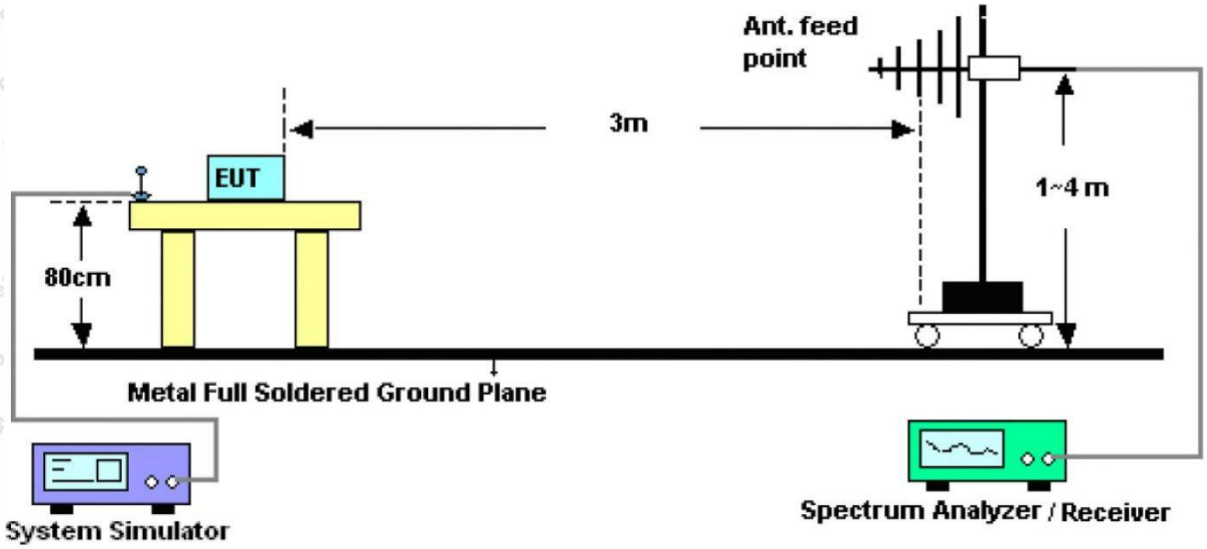


Figure 2. 30MHz to 1GHz

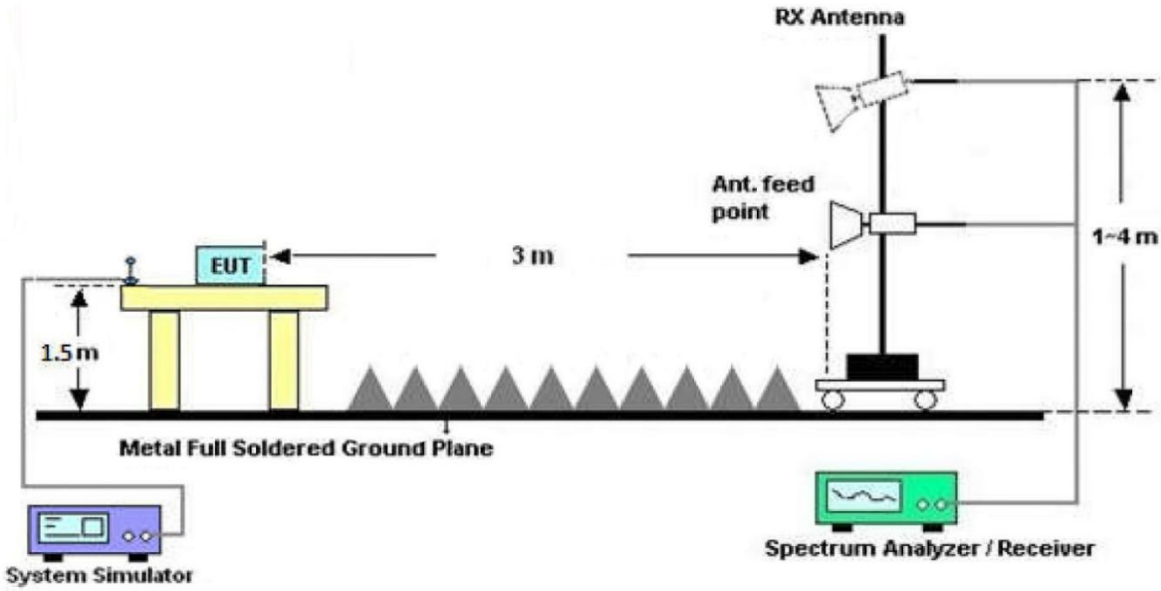


Figure 3. Above 1 GHz

4.3. Test Procedure

For below 1GHz: The EUT is placed on a turntable, which is 0.8m above the ground plane.

For above 1GHz: The EUT is placed on a turntable, which is 1.5m above the ground plane.

The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9*6*6 Chamber. The device is evaluated in xyz orientation.

For the radiated emission test above 1GHz:

Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW =1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as:

RBW = 9KHz, VBW =30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 30MHz to 1000MHz, Set the spectrum analyzer as:

RBW = 120kHz, VBW =300kHz,Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For above 1GHz,Set the spectrum analyzer as:

RBW =1MHz, VBW =3MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple.

For average measurement: use duty cycle correction factor method (DCCF)

Average level = Peak level + DCCF

4.4. Test Data

PASS

During the test, Pre-scan all kind of the place mode (X-axis, Y-axis, Z-axis), and found the X-axis is the worst case.

The test results of 9kHz-30MHz was attenuated more than 20dB below the permissible limits, so the results don't record in the report.

During the test, pre-scan all modes, only the worst case is recorded in the report.

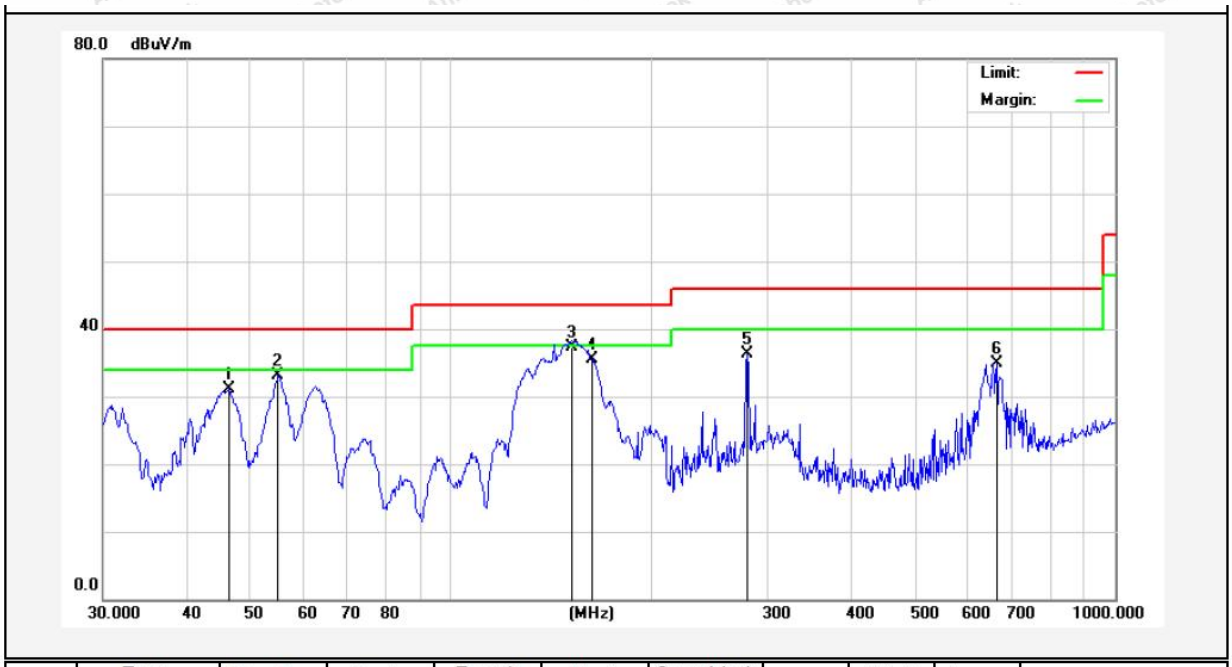
Test Results (30~1000MHz)

Test Mode: GFSK (2402MHz)

Power Source: DC 7.6V Battery inside

Polarization: Horizontal

Temp.(℃)/Hum.(%RH): 23.5℃/49%RH



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	46.5030	46.39	-15.37	31.02	40.00	-8.98	QP			
2	55.0274	50.75	-17.63	33.12	40.00	-6.88	QP			
3	152.1297	60.40	-23.11	37.29	43.50	-6.21	QP			
4	163.1818	59.45	-23.89	35.56	43.50	-7.94	QP			
5	279.0436	55.35	-18.98	36.37	46.00	-9.63	QP			
6	663.4729	45.30	-10.46	34.84	46.00	-11.16	QP			

Note: Result = Reading + Factor Over Limit = Result - Limit

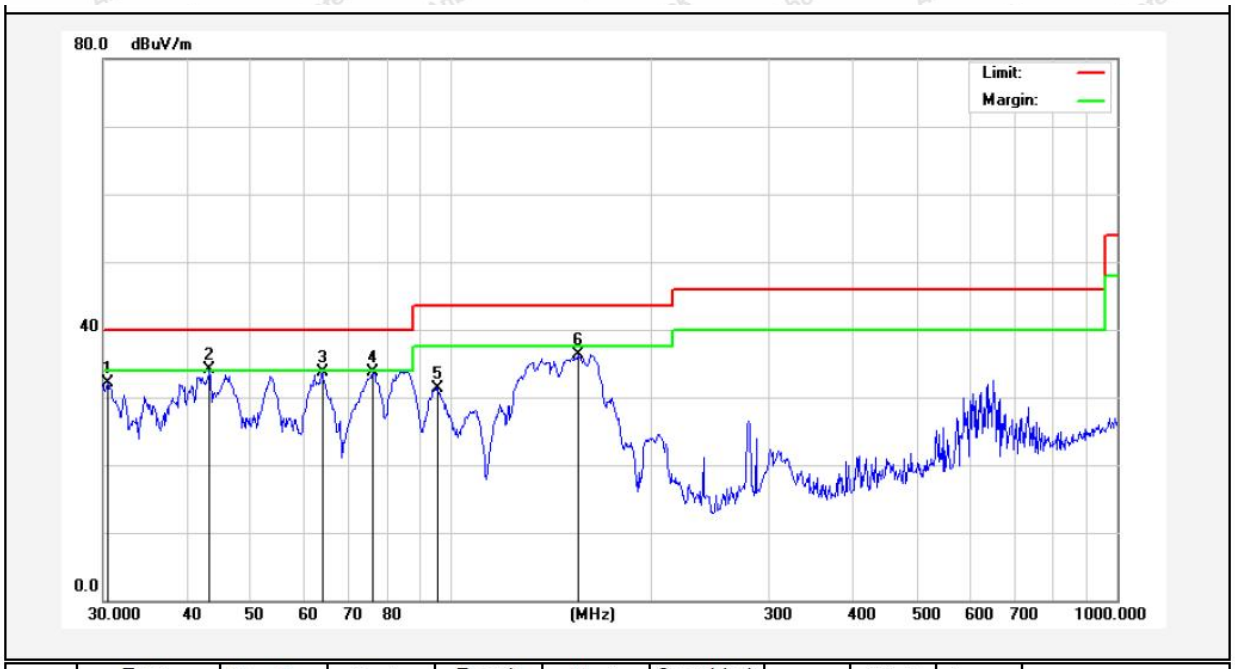
Test Results (30~1000MHz)

Test Mode: GFSK (2402MHz)

Power Source: DC 7.6V Battery inside

Polarization: Vertical

Temp.(℃)/Hum.(%RH): 23.5℃/49%RH



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	30.5305	50.07	-17.87	32.20	40.00	-7.80	QP			
2	43.3534	49.06	-14.89	34.17	40.00	-5.83	QP			
3	63.9827	52.58	-18.94	33.64	40.00	-6.36	QP			
4	76.2442	53.54	-19.75	33.79	40.00	-6.21	QP			
5	95.4270	48.54	-17.17	31.37	43.50	-12.13	QP			
6	154.8204	58.25	-21.88	36.37	43.50	-7.13	QP			

Note: Result = Reading + Factor Over Limit = Result - Limit

Test Results (1GHz-25GHz)

Test Mode: CH00			Test channel: Lowest			
Peak value:						
Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	polarization
4804.00	27.95	15.27	43.22	74.00	-30.78	Vertical
7206.00	28.98	18.09	47.07	74.00	-26.93	Vertical
9608.00	30.06	23.76	53.82	74.00	-20.18	Vertical
12010.00	*			74.00		Vertical
14412.00	*			74.00		Vertical
4804.00	28.26	15.27	43.53	74.00	-30.47	Horizontal
7206.00	29.43	18.09	47.52	74.00	-26.48	Horizontal
9608.00	28.57	23.76	52.33	74.00	-21.67	Horizontal
12010.00	*			74.00		Horizontal
14412.00	*			74.00		Horizontal
Average value:						
Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	polarization
4804.00	17.33	15.27	32.60	54.00	-21.40	Vertical
7206.00	18.01	18.09	36.10	54.00	-17.90	Vertical
9608.00	19.08	23.76	42.84	54.00	-11.16	Vertical
12010.00	*			54.00		Vertical
14412.00	*			54.00		Vertical
4804.00	16.61	15.27	31.88	54.00	-22.12	Horizontal
7206.00	18.49	18.09	36.58	54.00	-17.42	Horizontal
9608.00	17.88	23.76	41.64	54.00	-12.36	Horizontal
12010.00	*			54.00		Horizontal
14412.00	*			54.00		Horizontal

Test Results (1GHz-25GHz)

Test Mode: CH39			Test channel: Middle			
Peak value:						
Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	polarization
4882.00	27.97	15.42	43.39	74.00	-30.61	Vertical
7323.00	28.83	18.02	46.85	74.00	-27.15	Vertical
9764.00	29.07	23.80	52.87	74.00	-21.13	Vertical
12205.00	*			74.00		Vertical
14646.00	*			74.00		Vertical
4882.00	27.96	15.42	43.38	74.00	-30.62	Horizontal
7323.00	29.42	18.02	47.44	74.00	-26.56	Horizontal
9764.00	28.27	23.80	52.07	74.00	-21.93	Horizontal
12205.00	*			74.00		Horizontal
14646.00	*			74.00		Horizontal
Average value:						
Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	polarization
4882.00	17.06	15.42	32.48	54.00	-21.52	Vertical
7323.00	18.11	18.02	36.13	54.00	-17.87	Vertical
9764.00	18.94	23.80	42.74	54.00	-11.26	Vertical
12205.00	*			54.00		Vertical
14646.00	*			54.00		Vertical
4882.00	16.52	15.42	31.94	54.00	-22.06	Horizontal
7323.00	18.05	18.02	36.07	54.00	-17.93	Horizontal
9764.00	18.39	23.80	42.19	54.00	-11.81	Horizontal
12205.00	*			54.00		Horizontal
14646.00	*			54.00		Horizontal

Test Results (1GHz-25GHz)

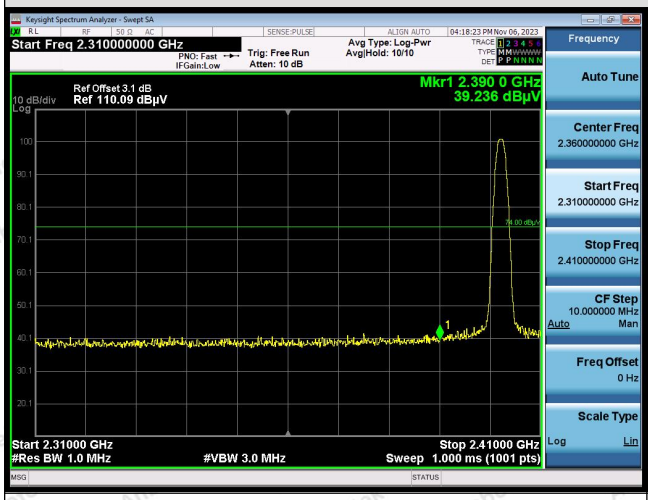
Test Mode: CH78			Test channel: Highest			
Peak value:						
Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	polarization
4960.00	28.24	15.58	43.82	74.00	-30.18	Vertical
7440.00	28.84	17.93	46.77	74.00	-27.23	Vertical
9920.00	29.62	23.83	53.45	74.00	-20.55	Vertical
12400.00	*			74.00		Vertical
14880.00	*			74.00		Vertical
4960.00	28.03	15.58	43.61	74.00	-30.39	Horizontal
7440.00	29.45	17.93	47.38	74.00	-26.62	Horizontal
9920.00	28.95	23.83	52.78	74.00	-21.22	Horizontal
12400.00	*			74.00		Horizontal
14880.00	*			74.00		Horizontal
Average value:						
Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	polarization
4960.00	18.18	15.58	33.76	54.00	-20.24	Vertical
7440.00	19.12	17.93	37.05	54.00	-16.95	Vertical
9920.00	19.49	23.83	43.32	54.00	-10.68	Vertical
12400.00	*			54.00		Vertical
14880.00	*			54.00		Vertical
4960.00	17.96	15.58	33.54	54.00	-20.46	Horizontal
7440.00	19.42	17.93	37.35	54.00	-16.65	Horizontal
9920.00	18.29	23.83	42.12	54.00	-11.88	Horizontal
12400.00	*			54.00		Horizontal
14880.00	*			54.00		Horizontal

Remark:

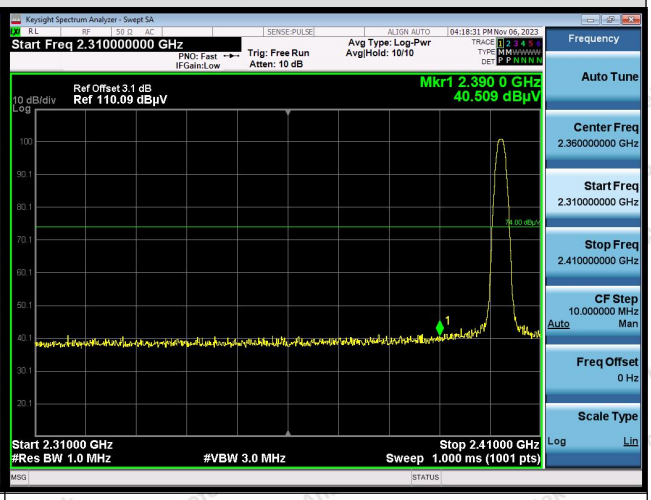
1. During the test, pre-scan the GFSK, π/4QPSK, 8DPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
2. Result =Reading + Factor
3. "*" means the test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.

Radiated Band Edge:

Test Mode: Lowest (CH00)

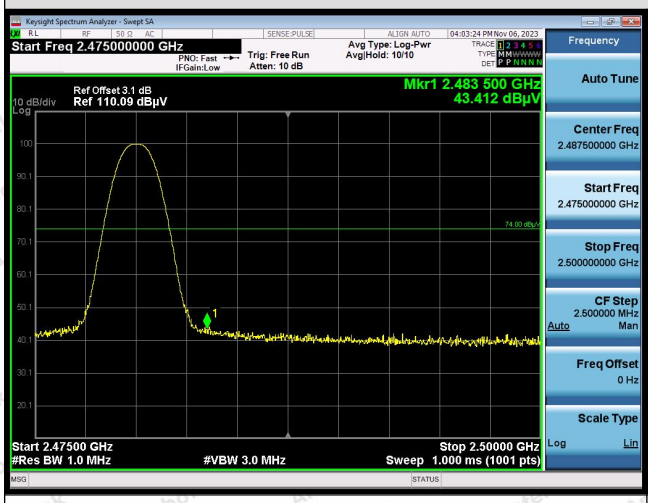


Peak Value(Vertical)

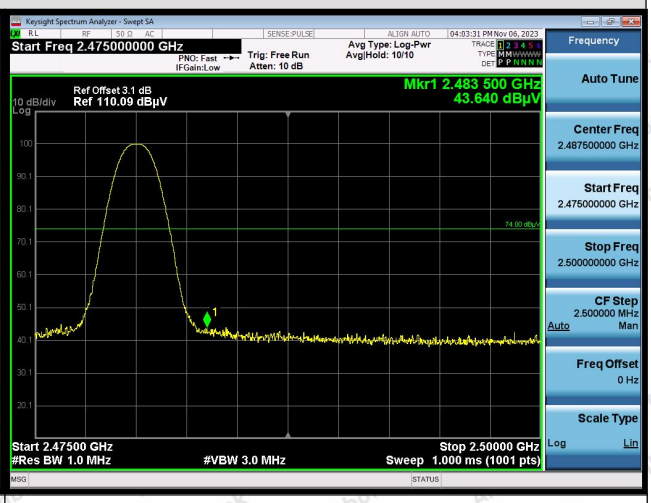


Peak Value(Horizontal)

Test Mode: Highest (CH78)



Peak Value(Vertical)



Peak Value(Horizontal)

Average:

Test Channel	Peak Value (dBuV/m)	DCCF	Average Value (dBuV/m)	Limit (dBuV/m)	Polarization	Verdict
CH00	39.236	-2.29	36.943	54.00	Vertical	Pass
	40.509	-2.29	38.216	54.00	Horizontal	Pass
CH78	43.412	-2.29	41.119	54.00	Vertical	Pass
	43.640	-2.29	41.347	54.00	Horizontal	Pass

Remark:

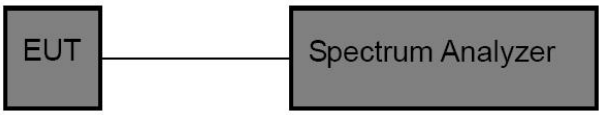
1. During the test, pre-scan the GFSK, π/4QPSK, 8DPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
2. DCCF=20log(Duty Cycle)
3. Average Value=Peak Value+DCCF

5. Maximum Peak Output Power Test

5.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (b)(1)
Test Limit	For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.

5.2. Test Setup



5.3. Test Procedure

1. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram above,
2. Spectrum Setting:
   RBW > the 20 dB bandwidth of the emission being measured
   Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel
   VBW ≥ RBW
   Sweep = auto
   Detector function = peak
   Trace = max hold

5.4. Test Data

Pass

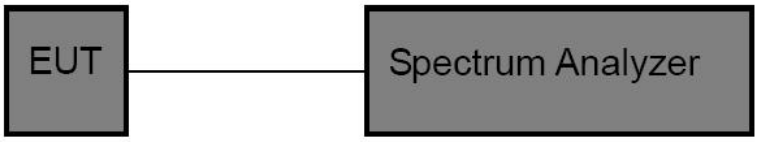
Please refer to Appendix C of the Appendix Test Data.

6. 20dB Occupy Bandwidth Test

6.1. Test Standard

Test Standard	FCC Part15 C Section 15.247 (a)(1)

6.2. Test Setup



6.3. Test Procedure

Using the following spectrum analyzer settings:

1. Span= approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel.
2. Set the RBW ≥1% of the 20 dB bandwidth.
3. Set the VBW ≥RBW
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

6.4. Test Data

Pass

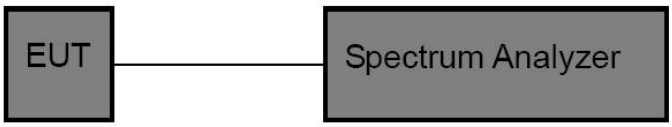
Please refer to Appendix A of the Appendix Test Data.

7. Carrier Frequency Separation Test

7.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (a)(1)
Test Limit	2/3 of the 20dB bandwidth base on the transmission power is less than 0.125W.

7.2. Test Setup



7.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer settings:

1. Span= Wide enough to capture the peaks of two adjacent channels
2. Set the RBW =approximately 30% of the channel spacing.
3. Set the VBW ≥ RBW.
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

7.4. Test Data

Pass

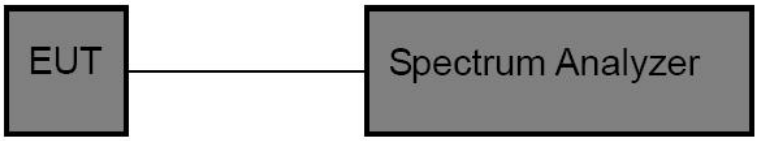
Please refer to Appendix D of the Appendix Test Data.

8. Number of Hopping Channel Test

8.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (a)(1)(iii)
Test Limit	>15 channels

8.2. Test Setup



8.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer setting:

1. Span= the frequency band of operation
2. Set the RBW = less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller.
3. Set the VBW ≥ RBW.
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

8.4. Test Data

Pass

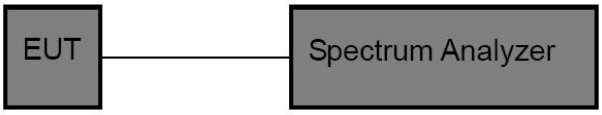
Please refer to Appendix F of the Appendix Test Data.

9. Dwell Time Test

9.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (a)(1)(iii)
Test Limit	0.4 s

9.2. Test Setup



9.3. Test Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

1. Span= zero span, centered on a hopping channel
2. Set the RBW = 1 MHz.
3. Set the VBW ≥ RBW.
4. Sweep time = as necessary to capture the entire dwell time per hopping channel.
5. Detector function = peak.
6. Trace mode = clear write.

9.4. Test Data

Pass

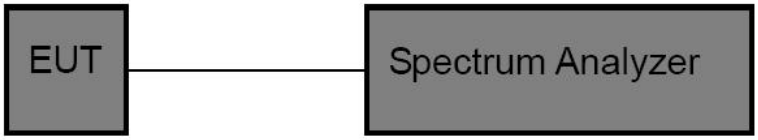
Please refer to Appendix E of the Appendix Test Data.

10. 100kHz Bandwidth of Frequency Band Edge Requirement

10.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (d)
Test Limit	In any 100 kHz bandwidth outside the frequency bands in which the spread spectrum intentional radiator in operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in 15.209(a).

10.2. Test Setup



10.3. Test Procedure

The EUT must have its hopping/Non-hopping function enabled. Using the following spectrum analyzer setting:

1. Set the RBW = 100kHz.
2. Set the VBW = 300kHz.
3. Sweep time = auto couple.
4. Detector function = peak.
5. Trace mode = max hold.
6. Allow trace to fully stabilize.

10.4. Test Data

Pass

Please refer to Appendix G & Appendix H of the Appendix Test Data.

11. Antenna Requirement

11.1. Test Standard and Requirement

Test Standard	FCC Part15 Section 15.203 /247(c)
Requirement	1) 15.203 requirement: An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. 2) 15.247(c) (1)(i) requirement: Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed. Point-to-point operations may employ transmitting antennas with directional gain greater than 6dBi provided the maximum conducted output power of the intentional radiator is reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6 dBi.

11.2. Antenna Connected Construction

The antenna is FPC Antenna which permanently attached, and the best case gain of the antenna is 3.16dBi. It complies with the standard requirement.

APPENDIX I -- TEST SETUP PHOTOGRAPH

Please refer to separated files Appendix I -- Test Setup Photograph

APPENDIX II -- EXTERNAL PHOTOGRAPH

Please refer to separated files Appendix II -- External Photograph

APPENDIX III -- INTERNAL PHOTOGRAPH

Please refer to separated files Appendix III -- Internal Photograph

---------- End of Report ----------